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May 2008

FDS6984AS

Dual Notebook Power Supply N-Channel PowerTrench® SyncFET[™] General Description Features

The FDS6984AS is designed to replace two single SO-8 MOSFETs and Schottky diode in synchronous DC:DC power supplies that provide various peripheral voltages for notebook computers and other battery powered electronic devices. FDS6984AS contains two unique 30V, N-channel, logic level, PowerTrench MOSFETs designed to maximize power conversion efficiency.

The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the low-side switch (Q2) is optimized to reduce conduction losses. Q2 also includes a patented combination of a MOSFET monolithically integrated with a Schottky diode.

 Q2: Optimized to minimize conduction losses Includes SyncFET Schottky diode

8.5A, 30V $R_{DS(on)}$ max= 20 m Ω @ V_{GS} = 10V

 $R_{DS(on)}$ max= 28 m Ω @ V_{GS} = 4.5V

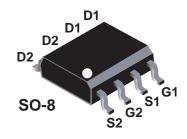
 Q1: Optimized for low switching losses Low gate charge (8nC typical)

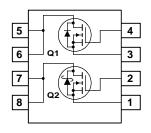
5.5A, 30V $R_{DS(on)}$ max= 31 m Ω @ V_{GS} = 10V

 $R_{DS(on)}$ max= 40 m Ω @ V_{GS} = 4.5V

RoHS Compliant







Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Q2	Q1	Units
V _{DSS}	Drain-Source Voltage		30	30	V
V _{GSS}	Gate-Source Voltage		±20	±20	V
I _D	Drain Current - Continuous	(Note 1a)	8.5	5.5	А
	- Pulsed		30	20	
P _D	Power Dissipation for Dual Operation		2	W	
	Power Dissipation for Single Operation	(Note 1a)	1	.6	
		(Note 1b)	,	1	
		(Note 1c)	0	.9	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150		°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

Package Marking and Ordering Information

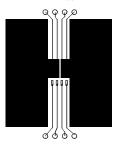
Device Marking	Device	Reel Size	Tape width	Quantity
FDS6984AS	FDS6984AS	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 1 mA V_{GS} = 0 V, I_D = 250 μ A	Q2 Q1	30 30			V
	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	Q2 Q1			500 1	μΑ
		$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125^{\circ}\text{C}$	Q2		2.3		mA
			Q1		79		nA
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	All			±100	nA
On Chai	racteristics (Note 2)						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 1 \text{ mA}$	Q2	1	1.7	3	V
(-)		$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	Q1	1	1.8	3	
$\Delta V_{GS(th)}$	Gate Threshold Voltage	I _D = 1 mA, Referenced to 25°C	Q2		-3		mV/°C
ΔT_J	Temperature Coefficient	$I_D = 250 \text{ uA}$, Referenced to 25°C	Q1		-4		
R _{DS(on)}	Static Drain-Source	$V_{GS} = 10 \text{ V}, I_D = 8.5 \text{ A}$	Q2		17	20	mΩ
, ,	On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 8.5 \text{ A}, T_J = 125^{\circ}\text{C}$			24	32	
		$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$			21	28	
		$V_{GS} = 10 \text{ V}, I_D = 5.5 \text{ A}$	Q1		26	31	
		$V_{GS} = 10 \text{ V}, I_D = 5.5 \text{ A}, T_J = 125^{\circ}\text{C}$			34	43	
		$V_{GS} = 4.5 \text{ V}, I_D = 4.6 \text{ A}$			32	40	
$I_{D(on)}$	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	Q2	30			Α
	Famour J. Tarana and J. Market	V 5 V L 0 5 A	Q1	20	0.5		0
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 8.5 \text{ A}$ $V_{DS} = 5 \text{ V}, I_{D} = 5.5 \text{ A}$	Q2 Q1		25 18		S
D		V _{DS} = 5 V, I _D = 5.5 A	Q I		10		
,	c Characteristics	V 45 V V 0 V			500		_
C _{iss}	Input Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz	Q2 Q1		530 420		pF
C _{oss}	Output Capacitance	= 1.0	Q1 Q2		170		pF
Coss	Output Capacitance		Q2 Q1		120		þr
Crss	Reverse Transfer Capacitance		Q2		60		pF
OISS	Travelse Transier Capacitance		Q1		50		Pi
R _G	Gate Resistance	V _{GS} = 15mV, f = 1.0 MHz	Q2		3.1		Ω
			Q1		2.2		

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Switchir	ng Characteristics (Note 2	2)		•			
t _{d(on)}	Turn-On Delay Time		Q2		8	16	ns
			Q1		9	18	
t _r	Turn-On Rise Time	$V_{DD} = 15 \text{ V}, I_D = 1 \text{ A},$	Q2 Q1		5 6	10 12	ns
t _{d(off)}	Turn-Off Delay Time	., ,,,,,	Q2		23	37	ns
- a(oii)	Tum on Bolay Time	$V_{GS} = 10V$, $R_{GEN} = 6 \Omega$	Q1		22	35	110
t _f	Turn-Off Fall Time	1	Q2		4	8	ns
			Q1		2	4	
t _{d(on)}	Turn-On Delay Time		Q2		9	18	ns
			Q1		10	19	
t _r	Turn-On Rise Time	$V_{DD} = 15 \text{ V}, I_D = 1 \text{ A},$	Q2 Q1		7 11	14 20	ns
t _{d(off)}	Turn-Off Delay Time	1	Q2		13	24	ns
Ca(OII)	Turn on Boldy Time	$V_{GS} = 4.5V$, $R_{GEN} = 6 \Omega$	Q1		13	24	110
t _f	Turn-Off Fall Time	1	Q2		4	8	ns
			Q1		3	6	
$Q_{g(TOT)}$	Total Gate Charge, Vgs = 10V		Q2		10	14	nC
		Q2:	Q1		8	11	
Q_g	Total Gate Charge, Vgs = 5V	$V_{DS} = 15 \text{ V}, I_D = 8.5 \text{ A}$	Q2 Q1		5 4	8 6	nC
Q _{qs}	Gate-Source Charge	-	Q1 Q2		1.5	О	nC
∠ gs	Gate-Source Charge	Q1:	Q1		1.3		110
Q_{gd}	Gate-Drain Charge	$V_{DS} = 15 \text{ V}, I_{D} = 5.5 \text{ A}$	Q2		1.9		nC
- ·gu			Q1		1.5		
Drain-S	Source Diode Characteri	stics and Maximum R	atings				
I _S	Maximum Continuous Drain-So					3.0	Α
						1.3	
t _{rr}	Reverse Recovery Time	$I_F = 10A$,	Q2		13		ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 300 \text{ A/}\mu\text{s}$ (No	ote 3)		6		nC
t _{rr}	Reverse Recovery Time	$I_F = 5.5A$,	Q1		17		ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100 \text{ A/}\mu\text{s}$ (No	ote 3)		6		nC
V _{SD}	Drain-Source Diode Forward	$V_{GS} = 0 \text{ V}, I_S = 2.3 \text{ A}$ (N	ote 2) Q2		0.6	0.7	V
	Voltage		ote 2) Q1		0.8	1.2	

Notes

1. $R_{\theta,JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in² pad of 2 oz copper



125°C/W when mounted on a 0.02 in² pad of 2 oz copper



) 135°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

- 2. See "SyncFET Schottky body diode characteristics" below.
- 3. Pulse Test: Pulse Width < $300\mu s,$ Duty Cycle < 2.0%

Typical Characteristics: Q2

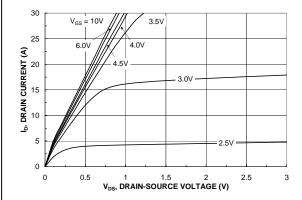
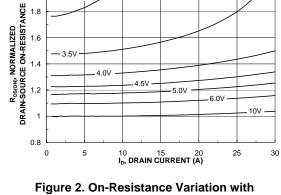


Figure 1. On-Region Characteristics.



 $V_{GS} = 3.0 V$

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

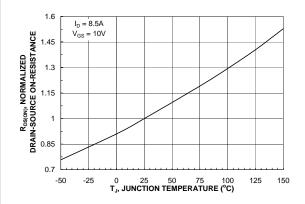


Figure 3. On-Resistance Variation with Temperature.

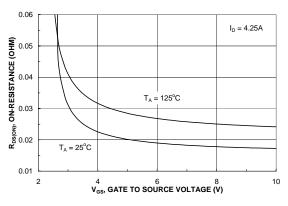


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

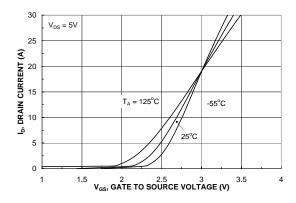


Figure 5. Transfer Characteristics.

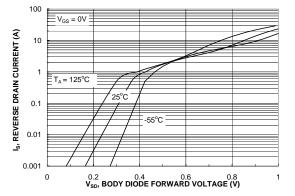


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q2

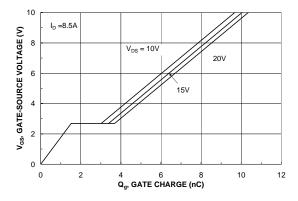


Figure 7. Gate Charge Characteristics.

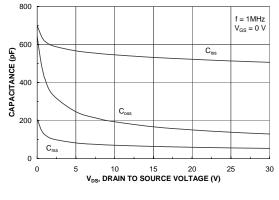


Figure 8. Capacitance Characteristics.

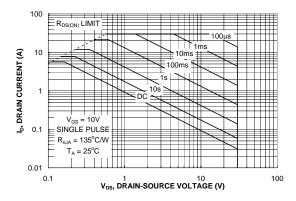


Figure 9. Maximum Safe Operating Area.

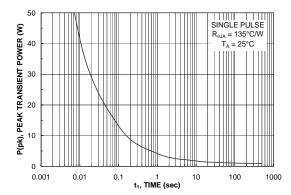


Figure 10. Single Pulse Maximum Power Dissipation.

Typical Characteristics Q1

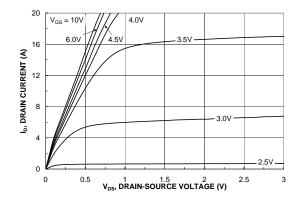


Figure 11. On-Region Characteristics.

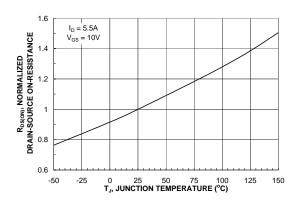


Figure 13. On-Resistance Variation with Temperature.

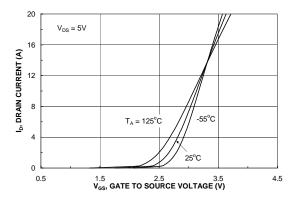


Figure 15. Transfer Characteristics.

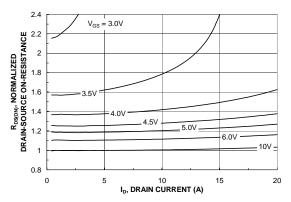


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

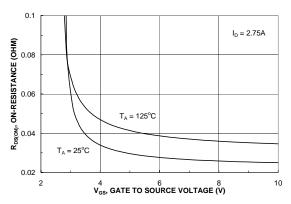


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

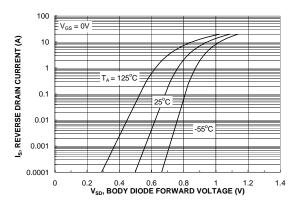
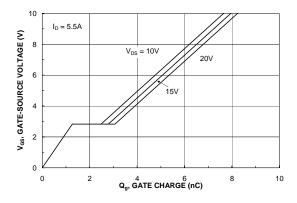


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics Q1



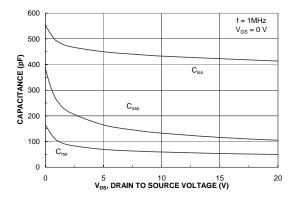
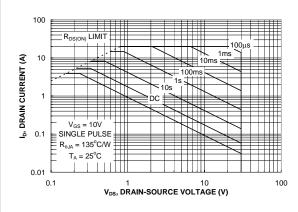


Figure 17. Gate Charge Characteristics.





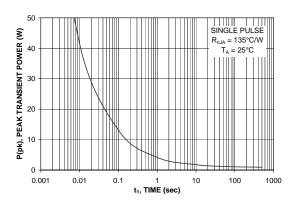


Figure 19. Maximum Safe Operating Area.

Figure 20. Single Pulse Maximum Power Dissipation.

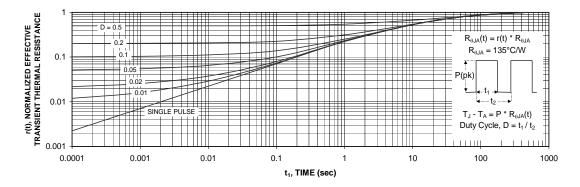


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

Typical Characteristics (continued)

SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 22 shows the reverse recovery characteristic of the FDS6984AS.

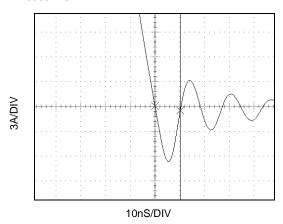


Figure 22. FDS6984AS SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 23 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6984A).

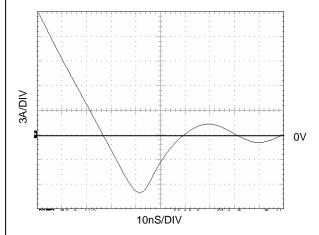


Figure 23. Non-SyncFET (FDS6984A) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

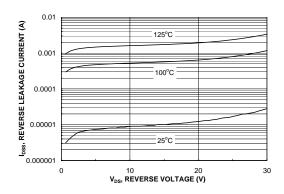


Figure 24. SyncFET body diode reverse leakage versus drain-source voltage and temperature.





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Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

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